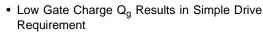
N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	650			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.95		
Q _g (Max.) (nC)	15			
Q _{gs} (nC)	3			
Q _{gd} (nC)	6			
Configuration	Single			

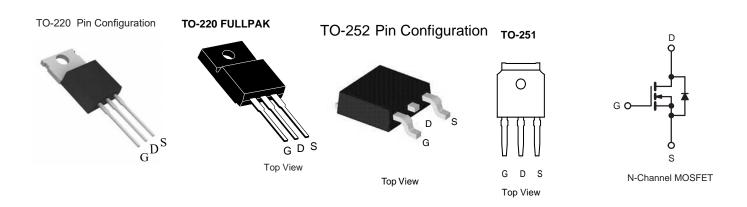
FEATURES





COMPLIANT

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC



ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30		
Continuous Drain Current ^e	V _{GS} at 10 V	T _C = 25 °C	- I _D	5		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C		4	Α	
Pulsed Drain Current ^a			I _{DM}	16		
Linear Derating Factor				1.67/0.8/0.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	120	mJ	
Repetitive Avalanche Current ^a			I _{AR}	34	Α	
Repetitive Avalanche Energy ^a			E _{AR}	17	mJ	
Maximum Power Dissipation	er Dissipation $T_C = 25 ^{\circ}C$			205/35/30	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)d	for 10 s			300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 24 mH, R_G = 25 Ω , I_{AS} = 3.2 A (see fig. 12). c. I_{SD} \leq 3.2 A, dI/dt \leq 90 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.

- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



DTP5N65SJ/DTP5N65FSJ/DTU5N65SJ/DTL5N65SJ

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	TYP. MAX.		
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6/1.2/0.6	C/VV	

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	V _{GS} = 0 V, I _D = 250 μA		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA ^d		0.6	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		ı	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125 ^{\circ}\text{C}$		-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.5 A ^b	-	0.95	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	V _{DS} = 50 V, I _D = 2.5 A		-	-	S
Dynamic					•		1
Input Capacitance	C _{iss}	V _{GS} = 0 V,		-	320	-	-
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$		75	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	4	-	
Output Capacitance	C _{oss}	C	V _{DS} = 1.0 V, f = 1.0 MHz	-	500	-	pF -
Output Capacitance		$V_{GS} = 0 V$	V _{DS} = 520 V, f = 1.0 MHz	-	83	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 \text{ V to } 520 \text{ V}^{c}$	-	14	-	
Total Gate Charge	Q_g		V I _D = 2.5 A, V _{DS} = 400 V see fig. 6 and 13 ^b	ı	-	15	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	3	
Gate-Drain Charge	Q_{gd}			-	-	6	
Turn-On Delay Time	t _{d(on)}		V _{DD} = 325 V, I _D = 3.2 A		18	-	ns
Rise Time	t _r				40	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.1 \Omega$, $R_D = 62 \Omega$, see fig. 10^b		-	50	-	
Fall Time	t _f			-	30	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the integral reverse p - n junction diode		-	5	- A
Pulsed Diode Forward Current ^a	I _{SM}				-	16	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.2 A, dI/dt = 100 A/µs ^b		-	180	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- d. t = 60 s, f = 60 Hz.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

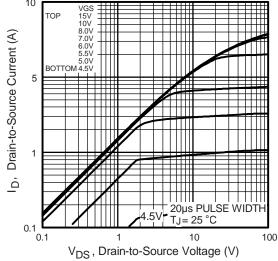


Fig. 1 - Typical Output Characteristics

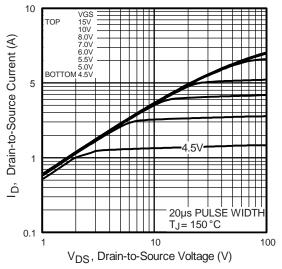


Fig. 2 - Typical Output Characteristics

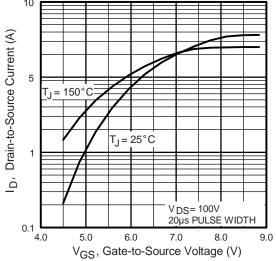


Fig. 3 - Typical Transfer Characteristics

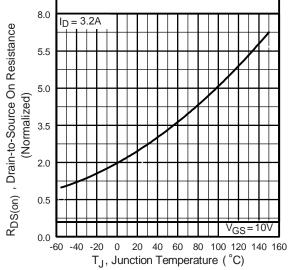


Fig. 4 - Normalized On-Resistance vs. Temperature

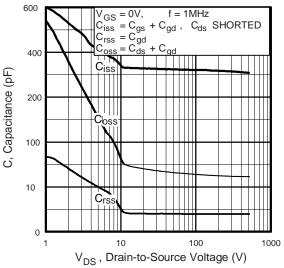


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

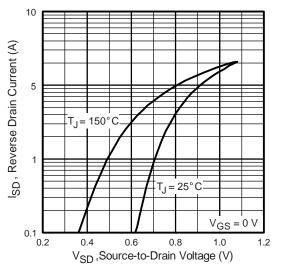


Fig. 7 - Typical Source-Drain Diode Forward Voltage

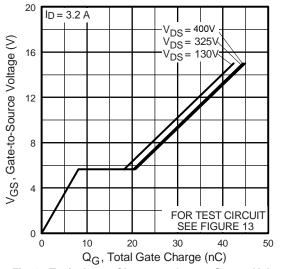


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

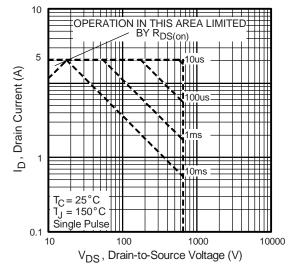


Fig. 8 - Maximum Safe Operating Area

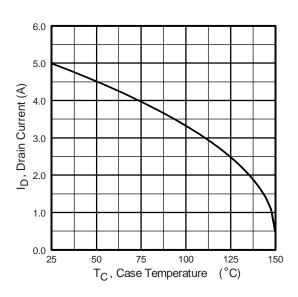


Fig. 9 - Maximum Drain Current vs. Case Temperature

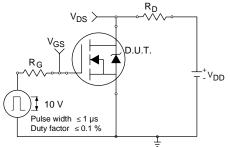


Fig. 10a - Switching Time Test Circuit

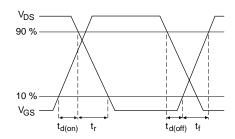


Fig. 10b - Switching Time Waveforms

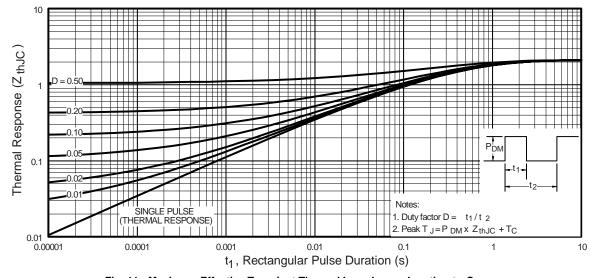


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

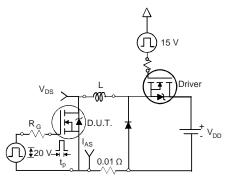


Fig. 12a - Unclamped Inductive Test Circuit

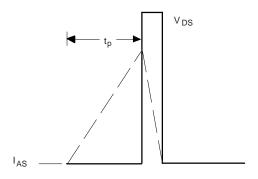


Fig. 12b - Unclamped Inductive Waveforms

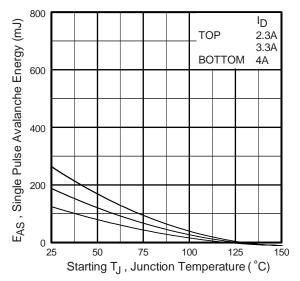


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

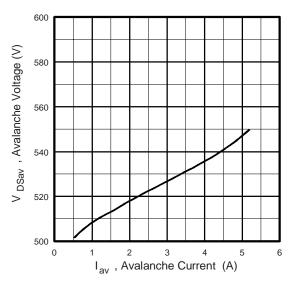


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche
Current

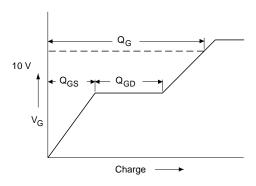


Fig. 13a - Basic Gate Charge Waveform

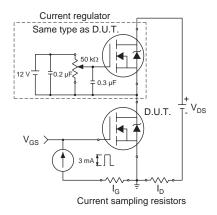
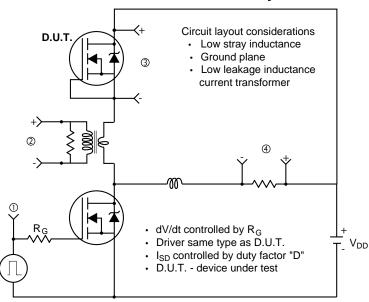
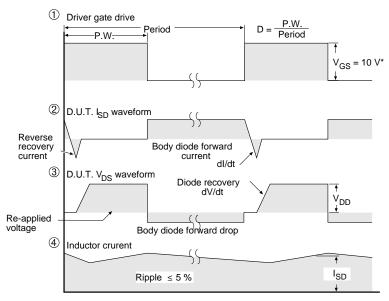


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel





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